

**Search Notes**

Application/Control No.

10/779,858

Examiner

Tomasz Ponikiewski

Applicant(s)/Patent under  
Reexamination

MEYER, FRANK

Art Unit

2165

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search	10/2/2006	TP
Checked East DB for double patenting	10/2/2006	TP
USPT, PGPB,JPAB,EPO,DWPI,TDBG	10/2/2006	TP
Consulted with Neveen Abel-Jalil	10/2/2006	TP